Ordering number : ENA0279



## SANYO Semiconductors DATA SHEET

NPN Epitaxial Planar Silicon Transistor

# 2SC6082 - 50V / 15A High-Speed Switching Applications

#### **Applications**

· High-speed switching applications (switching regulator, driver circuit).

#### **Features**

- Adoption of MBIT process.
- · Large current capacitance.
- · Low collector-to-emitter saturation voltage.
- · High-speed switching.

### **Specifications**

#### Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	VCBO		60	V
Collector-to-Emitter Voltage	VCES		60	V
Collector-to-Emitter Voltage	VCEO		50	V
Emitter-to-Base Voltage	VEBO		6	V
Collector Current	IC		15	Α
Collector Current (Pulse)	ICP	PW≤10μs, duty cycle≤10%	20	Α
Base Current	IB		3	Α
Collector Dissipation	D-	900 7 4 2	2	W
	PC	Tc=25°C	25	W
Junction Temperature	Tj		150	°C
Storage Temperature	Tstg	COM	-55 to +150	°C

#### Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions		Ratings		
			min	typ	max	Unit
Collector Cutoff Current	ICBO	V <sub>CB</sub> =40V, I <sub>E</sub> =0A			10	μΑ
Emitter Cutoff Current	IEBO	V <sub>EB</sub> =4V, I <sub>C</sub> =0A		M-1	10	μΑ
DC Current Gain	hFE1	V <sub>CE</sub> =2V, I <sub>C</sub> =330mA	200	100	560	
	hFF2	VCE=2V, IC=10A	50	W 78 T		

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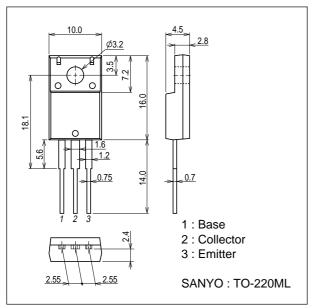
#### 2SC6082

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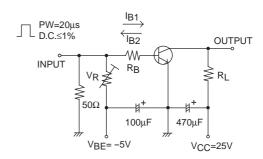
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Offic
Gain-Bandwidth Product	fT	V <sub>CE</sub> =10V, I <sub>C</sub> =2A		195		MHz
Output Capacitance	Cob	V <sub>CB</sub> =10V, f=1MHz		85		pF
Collector-to-Emitter Saturation Voltage	V <sub>CE</sub> (sat)	I <sub>C</sub> =7.5A, I <sub>B</sub> =375mA		200	400	mV
Base-to-Emitter Saturation Voltage	V <sub>BE</sub> (sat)	I <sub>C</sub> =7.5A, I <sub>B</sub> =375mA			1.2	V
Collector-to-Base Breakdown Voltage	V(BR)CBO	I <sub>C</sub> =100μA, I <sub>E</sub> =0A	60			V
Collector-to-Emitter Breakdown Voltage	V(BR)CES	I <sub>C</sub> =100μA, R <sub>BE</sub> =0Ω	60			V
Collector-to-Emitter Breakdown Voltage	V(BR)CEO	IC=1mA, RBE=∞	50			V
Emitter-to-Base Breakdown Voltage	V(BR)EBO	I <sub>E</sub> =100μA, I <sub>C</sub> =0A	6			V
Turn-ON Time	ton	See specified Test Circuit.		52		ns
Storage Time	tstg	See specified Test Circuit.		560		ns
Fall Time	tf	See specified Test Circuit.		37		ns

#### **Package Dimensions**

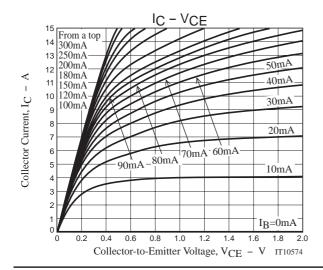
unit : mm 7508-002

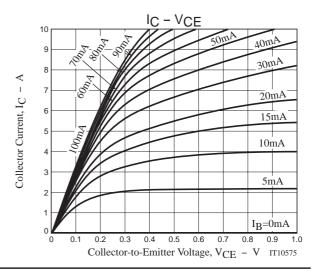


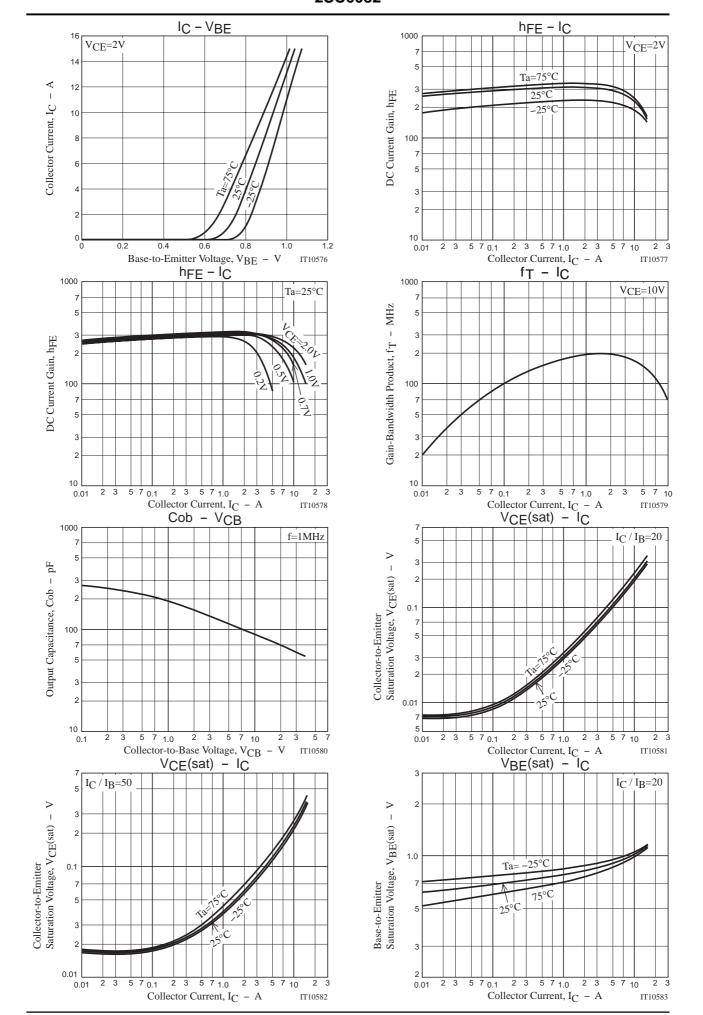
#### **Switching Time Test Circuit**



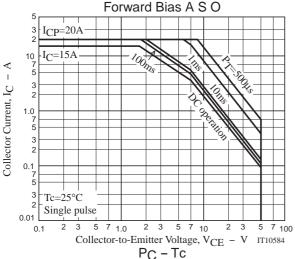
$$I_{C}=20I_{B1}=-20I_{B2}=5A$$

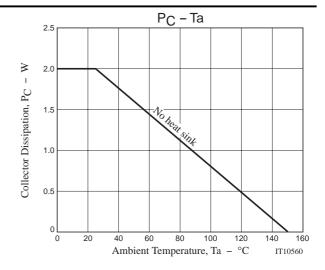


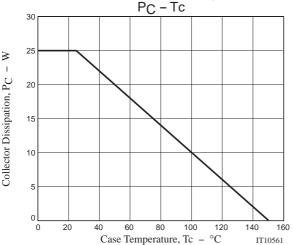




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